Signal Reconstruction Errors in Jittered Sampling

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Abstract—One of the most significant types of error in digital signal processing (DSP) systems working with wideband signals is the error introduced by the analog-to-digital (AD) and digital-to-analog (DA) converters. This paper presents an accurate and simple method to evaluate the performance of AD/DA converters affected by clock jitter, which is based on the analysis of the mean square error (MSE) between the reconstructed signal and the original one. Using an approximation of the linear minimum MSE (LMMSE) filter as reconstruction technique, we derive analytic expressions of the MSE. In particular, through asymptotic analysis, we are able to simply evaluate the performance of digital signal reconstruction as a function of the clock jitter, number of quantization bits, signal bandwidth and sampling rate.

Index Terms—Analog-digital conversion, error analysis, signal reconstruction, signal sampling.

I. INTRODUCTION

SIGNIFICANT problem in analog-digital conversion (ADC) of wideband signals is clock jitter and its impact on the quality of signal reconstruction [i.e., digital-analog conversion (DAC)] [1], [2]. Indeed, even small amounts of jitter can measurably degrade the performance of analog-to-digital (AD) and digital-to-analog (DA) converters; as an example, for a 24-bit quantized audio signal, jitter greater than 3–5 ps can already be extremely harmful.

Clock jitter is typically detrimental because the analog to digital process relies upon a sample clock to indicate when a sample or snap shot of the analog signal is taken. In order to accurately represent the analog data, the sample clock must be evenly spaced in time. Any deviation will result in a distortion of the digitization process since, once an analog signal is converted, it is virtually impossible to recreate the small timing variations in such a way as to reassemble the digital signal back to analog in its original form. If one had a perfect ADC and a perfect DAC and used the same clock to drive both units, then jitter would not have any impact on the reconstructed signal. In a real-world system, however, a digitized signal travels through

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multiple processors, usually it is stored on a disk or piece of tape for a while, and then goes through more processing before being converted back to analog. Thus, during reconstruction, the clock pulses used to sample the signal are replaced with newer ones with their own subtle variations. Note that, a given amount of clock jitter has a greater effect as the signal amplitude and frequency increase, since in both cases the change in unit time of the signal is greater with high-level, high-frequency signals. Furthermore, depending on the sources, jitter may have different probability distributions, and different probability distributions may have different effects on the quality of the reconstructed signal. In particular, wideband noise generates a randomly distributed jitter and manifests as increased noise and distortion in the signal [3]–[5], hence leading to a decrease in the signal-to-noise ratio (SNR).

While several results are available in the literature on jittered sampling [6], [7] as well as on experimental measurements and instruments performance [3], [5], [8], [9], an analytical methodology for the performance study of the AD/DA conversion is still missing.

In this paper we fill this gap and propose a method for evaluating the performance of AD/DC converters affected by jitter, which is based on the analysis of the mean square error (MSE) between the reconstructed signal and the original one [9].

The problem of signal reconstruction from irregularly spaced samples (which represent a more general case with respect to jittered samples) has been addressed by several works in the field of signal processing (see, e.g., [10]–[12]), and many reconstruction techniques have been proposed. Here, as reconstruction technique, we consider linear filtering, which has the advantage of enabling a theoretical analysis, unlike other approaches such as iterative or nonlinear techniques. Furthermore, linear filters have been used in a wide variety of fields such as MIMO communication systems [13], multiuser detection [14], and reconstruction of physical fields sampled by sensor networks [15]. In particular, in our previous work [15] we showed that physical fields can be reconstructed with high reliability from an irregularly deployed sensor network whose nodes are characterized by random positions which are known (up to some errors) to the reconstruction algorithm. The analytic approach employed in [15] for deriving the expression of the reconstruction performance is similar to that proposed here for jittered sampling. However, unlike [15], this work deals with regularly spaced samples affected by unknown jitter. This setting leads to a totally different matrix representing the sampling system and to a completely different set of equations and results with respect to those presented in [15].

Notice that if jitter is known exactly, the linear minimum MSE (LMMSE) reconstruction technique is optimal in the mean-square sense since it minimizes the MSE of the reconstructed signal. In practice this is not the case, hence we apply a reconstruction filter with the same structure of the LMMSE filter, where we let the jitter vanish. Then, we apply asymptotic analysis to derive analytical expressions of the MSE on the quality of the reconstructed signal. Through numerical results, we show that our asymptotic expressions provide an excellent approximation of the MSE even for small values of the system parameters, with the advantage of greatly reducing the computation complexity. In particular, we look at two different probability distributions of the jitter, namely, Gaussian and uniform distribution, and show that our asymptotic approach provides an excellent approximation of the MSE. Finally, we apply our method to study the performance of the AD/DA conversion system as a function of the clock jitter, number of quantization bits, signal bandwidth and sampling rate.

II. SYSTEM MODEL

A. Notations

Column vectors are denoted by bold lowercase letters and matrices are denoted by bold upper case letters. The (k,q)th entry of the generic matrix \mathbf{Z} is denoted by $(\mathbf{Z})_{k,q}$. The $n \times n$ identity matrix is denoted by \mathbf{I}_n , while \mathbf{I} is the generic identity matrix. $(\cdot)^{\mathrm{T}}$ is the transpose operator, while $(\cdot)^{\dagger}$ is the conjugate transpose operator. We denote by $f_x(z)$ the probability density function (pdf) of the generic random variable x, and by $\mathbb{E}[\cdot]$ the average operator.

B. Sampling and Reconstruction Quality

We consider an analog signal s(t) sampled at constant rate $f_s=1/T_s$ over the finite interval $[0,MT_s)$, where T_s is the sample spacing. When observed over a finite interval, s(t) admits an infinite Fourier series expansion. Let N' denote the largest index of the non-negligible Fourier coefficients, then N'/T_s can be considered as the approximate one-sided bandwidth of the signal. We therefore represent the signal by using a truncated Fourier series with N=2N'+1 complex harmonics:

$$s(t) = \frac{1}{\sqrt{N}} \sum_{\ell=-N'}^{N'} a_{\ell} \exp\left(j2\pi \ell \frac{t}{MT_s}\right)$$
 (1)

 $0 \le t < MT_s$. The complex vector $\mathbf{a} = [a_{-N'}, \dots, a_0, \dots, a_{N'}]^{\mathrm{T}}$ represents the discrete spectrum of the signal. Observe that the signal representation given in (1) includes sine waves of any fractional frequency $f_0 = f_s N'/M$ (when $a_\ell = 0$ for $-N' < \ell < N'$ and $a_{-N'} = a_{N'}^*$), which are frequently used as reference signal for calibration of ADC [3], [4]. Furthermore, we note that when the signal s(t) is observed in the

frequency domain through its M samples, the spectral resolution is given by

$$\Delta f = \frac{1}{MT_s}.$$

Therefore, considering the expression in (1), the signal bandwidth is given by

$$B = \frac{N\Delta f}{2} = \frac{N}{2MT_s}.$$

By defining the parameter β as

$$\beta = \frac{M}{N} \tag{2}$$

we can also write

$$B = \frac{f_s/2}{\beta}. (3)$$

From (3) it is clear that the parameter β represents the *oversam-pling factor* of the signal s(t) beyond the Nyquist rate.

In this work, we consider that sampling locations suffer from jitter, i.e., the *m*th sampling location is given by

$$t_m = mT_s + d_m, \quad m = 0, \dots, M - 1$$
 (4)

where d_m is the associated independent random jitter whose distribution is denoted by $f_d(z)$. Typically, we have $|d_m| \ll T_s$.

Let the signal samples be $\mathbf{s} = [s_0, \dots, s_{M-1}]^T$ where $s_m = s(t_m), 0 \le m \le M-1$. Using (1), the set of signal samples can be written as

$$\mathbf{s} = V^\dagger \mathbf{a}$$

where V is an $N \times M$ Vandermonde matrix defined as

$$(\mathbf{V})_{\ell,m} = \frac{1}{\sqrt{N}} \exp\left(-j2\pi \ell \frac{t_m}{MT_s}\right)$$
 (5)

 $\ell = -N', \dots, N'$, and $m = 0, \dots, N-1$. Note that **V** accounts for the jitter in the AD/DA conversion process, and that the parameter β defined in (2) also represents the *aspect ratio* of matrix **V**.

Furthermore, in addition to jittered sampling, we assume that signal samples are affected by some additive noise and are therefore given by

$$y = s + n$$

where \mathbf{n} is a vector of M noise samples, modeled as zero mean i.i.d. random variables. In practice, the dominant additive noise error is due to the n-bit quantization process [17].

 1 The aspect ratio of an $N \times M$ matrix is the ratio between the number of columns and the number of rows.

Now, let us consider a reconstruction technique that provides an estimate $\hat{\mathbf{a}}$ of the discrete spectrum \mathbf{a} , and let $\hat{s}(t)$ be the reconstruction of s(t) obtained from $\hat{\mathbf{a}}$, i.e.,

$$\hat{s}(t) = \frac{1}{\sqrt{N}} \sum_{\ell=-N'}^{N'} \hat{a}_{\ell} \exp\left(j2\pi \ell \frac{t}{MT_s}\right).$$

We consider as performance metric of the AD/DA conversion process the mean square error (MSE) associated to the estimate. The MSE, evaluated in the observation interval $[0, MT_s)$, can be equivalently computed in both time and frequency domains as shown below:

$$MSE = \mathbb{E}\left[\int_{0}^{MT_{s}} |s(t) - \hat{s}(t)|^{2} dt\right]$$

$$= \frac{1}{N} \mathbb{E}\left[\int_{0}^{MT_{s}} \left| \sum_{\ell=-N'}^{N'} e^{j2\pi\ell \frac{t}{MT_{s}}} (a_{\ell} - \hat{a}_{\ell}) \right|^{2} dt\right]$$

$$= \frac{1}{N} \sum_{\ell,h=-N'}^{N'} \sum_{h=-N'}^{N'} \mathbb{E}\left[(a_{\ell} - \hat{a}_{\ell})(a_{h} - \hat{a}_{h})^{*}\right]$$

$$\cdot \int_{0}^{MT_{s}} e^{j2\pi(\ell-h) \frac{t}{MT_{s}}} dt$$

$$= \frac{1}{N} \sum_{k=-N'}^{N'} \mathbb{E}\left[|a_{\ell} - \hat{a}_{\ell}|^{2}\right] = \frac{1}{N} \mathbb{E}\left[||\mathbf{a} - \hat{\mathbf{a}}||^{2}\right]. \quad (6)$$

More specifically, we consider as performance metric of the signal reconstruction the MSE relative to the signal average power:

$$J = \frac{\text{MSE}}{\sigma_a^2}$$

which can be thought of as a noise-to-signal ratio and will be plotted in a decibel scale in our results.

Among the possible techniques that can be applied to reconstruct the original signal, we focus on linear filters. Linear filtering provides an estimate of a through the linear operation

$$\hat{\mathbf{a}} = \mathbf{B}\mathbf{y}$$

where ${\bf B}$ is an $N \times M$ matrix. Below, we present the linear reconstruction filter that we apply to the case of jittered ADC/DAC systems.

III. JITTERED AD/DA CONVERSION WITH LINEAR FILTERING

Let us assume $\|\mathbf{a}\|^2 = \sigma_a^2 N$ and $\mathbb{E}[\mathbf{n}\mathbf{n}^{\dagger}] = \sigma_n^2 \mathbf{I}$, then we define the SNR in absence of jitter as

$$\gamma = \frac{\sigma_a^2}{\sigma_n^2}$$
.

Under the assumption that $\mathbb{E}[\mathbf{a}\mathbf{a}^{\dagger}] = \sigma_a^2 \mathbf{I}$, the linear filter that provides the best performance in terms of MSE is the LMMSE filter, which is given by [14]

$$\mathbf{B}_{\text{opt}} = \left(\mathbf{V}\mathbf{V}^{\dagger} + \frac{1}{\gamma}\mathbf{I}\right)^{-1}\mathbf{V}.\tag{7}$$

In [15], it has been shown that, by applying the LMMSE, we obtain

$$J = \frac{1}{\sigma_a^2 N} \mathbb{E}\left[\|\mathbf{a} - \hat{\mathbf{a}}\|^2 \right] = \mathbb{E}\left[\operatorname{tr}\left\{ (\gamma \mathbf{V} \mathbf{V}^\dagger + \mathbf{I})^{-1} \right\} \right]$$

where $tr\{\cdot\}$ is the normalized matrix trace operator.

Note, however, that the filter in (7) cannot be employed in practice, since the jitters d_m (hence the matrix \mathbf{V}) are unknown [see the definition of \mathbf{V} in (5)]. We therefore resort to an approximation of the optimum filter $\mathbf{B}_{\mathrm{opt}}$, based on the assumption that jitter has a zero mean.

In particular, we approximate ${\bf V}$ with the matrix ${\bf F}$ defined as

$$\mathbf{F} = \mathbf{V}|_{d_m = 0}$$

with the generic element of \mathbf{F} given by

$$(\mathbf{F})_{\ell,m} = \frac{1}{\sqrt{N}} \exp\left(-j2\pi\ell \frac{m}{M}\right)$$

 $\ell = -N', \dots, N'$, and $m = 0, \dots, N-1$. We observe that **F** has the following property:

$$\mathbf{F}\mathbf{F}^{\dagger} = \beta \mathbf{I}$$

and it is related to the discrete Fourier transform matrix. Substituting the approximation of V in (7), we obtain:

$$\mathbf{B} = \left(\beta + \frac{1}{\gamma}\right)^{-1} \mathbf{F}.\tag{8}$$

Notice that the filter in (8) is the LMMSE filter adapted to the linear model $\mathbf{y} = \mathbf{F}^{\dagger}\mathbf{a} + \mathbf{n}$. By letting $\omega = (\beta + 1/\gamma)^{-1}$, the noise to signal ratio J provided by the approximate filter (8) is given by

$$J = \frac{1}{\sigma_a^2 N} \mathbb{E} \left[||\mathbf{a} - \omega \mathbf{F} \mathbf{y}||^2 \right]$$

$$= \frac{1}{\sigma_a^2 N} \mathbb{E} \left[||(\omega \mathbf{F} \mathbf{V}^{\dagger} - \mathbf{I}) \mathbf{a} + \omega \mathbf{F} \mathbf{n}||^2 \right]$$

$$= \operatorname{tr} \left\{ \mathbb{E}_d \left[(\omega \mathbf{F} \mathbf{V}^{\dagger} - \mathbf{I}) (\omega \mathbf{V} \mathbf{F}^{\dagger} - \mathbf{I}) \right] + \frac{\omega^2 \beta}{\gamma} \mathbf{I} \right\}$$

$$= \operatorname{tr} \left\{ \omega^2 \mathbb{E}_d \left[\mathbf{F} \mathbf{V}^{\dagger} \mathbf{V} \mathbf{F}^{\dagger} \right] - 2\omega \Re \mathbb{E}_d \left[\mathbf{F} \mathbf{V}^{\dagger} \right] + \frac{\gamma + \omega^2 \beta}{\gamma} \mathbf{I} \right\}$$
(9)

where the operator $\mathbb{E}_d[\cdot]$ averages over the random jitters $d_m, m = 0, \dots, M-1$.

Assuming that the jitters are independent [3] and considering that the jitter characteristic function is $C_d(w) = \mathbb{E}_d[\exp(jwz)]$,

in Appendix A we derive the following expressions for the two terms in (9):

$$\operatorname{tr}\left\{\mathbb{E}_{d}[\mathbf{F}\mathbf{V}^{\dagger}]\right\} = \frac{\beta}{N} \sum_{\ell=-N'}^{N'} C_{d}\left(\frac{2\pi\ell}{MT_{s}}\right)$$

$$\operatorname{tr}\left\{\mathbb{E}_{d}[\mathbf{F}\mathbf{V}^{\dagger}\mathbf{V}\mathbf{F}^{\dagger}]\right\}$$
(10)

$$= \beta + \beta \frac{(\beta - 1)}{N} \sum_{\ell = -N'}^{N'} \left| C_d \left(\frac{2\pi \ell}{MT_s} \right) \right|^2. \tag{11}$$

Hence, we write the noise to signal ratio J as

$$J = 1 + \omega^2 \beta \left(1 + \frac{1}{\gamma} \right) - 2\omega \frac{\beta}{N} \sum_{\ell = -N'}^{N'} C_d \left(\frac{2\pi \ell}{MT_s} \right) + \omega^2 \beta \frac{(\beta - 1)}{N} \sum_{\ell = -N'}^{N'} \left| C_d \left(\frac{2\pi \ell}{MT_s} \right) \right|^2. \quad (12)$$

In order to reduce the complexity of the computation of the reconstruction error and provide simple but accurate analytical tools, in the next section we let the parameters N and M go to infinity, while the ratio $\beta=M/N$ is kept constant. We therefore derive an asymptotic expression of J, which we will show to well approximate the expression in (12).

IV. ASYMPTOTIC ANALYSIS

When the parameters N and M grow to infinity while β is kept constant, we define the asymptotic noise-to-signal ratio J as

$$J_{\infty}^{(\beta,\gamma)} = \lim_{N,M \to +\infty \atop \beta} J.$$

In [15], it has been shown that $J_{\infty}^{(\beta,\gamma)}$ provides an excellent approximation of MSE/σ_a^2 even for small values of N and M, with the advantage of greatly simplifying the computation.

In the limit $N, M \to \infty$ with constant β , we compute

$$\mu_{1} = \lim_{N, M \to +\infty} \frac{1}{N} \sum_{\ell=-N'}^{N'} C_{d} \left(\frac{2\pi\ell}{MT_{s}} \right)$$

$$= \lim_{N, M \to +\infty} \frac{1}{N} \sum_{\ell=-N'}^{N'} C_{d} \left(\frac{2\pi\ell}{\beta NT_{s}} \right)$$

$$= \int_{-1/2}^{1/2} C_{d} \left(\frac{2\pi x}{\beta T_{s}} \right) dx$$

$$= \int_{-1/2}^{1/2} C_{d} (4\pi Bx) dx. \tag{13}$$

where, from (3), we used the fact that $1/\beta T_s = f_s/\beta = 2B$. Similarly, we define

$$\mu_{2} = \lim_{N,M \to +\infty} \frac{1}{N} \sum_{\ell=-N'}^{N'} C_{d} \left(\frac{2\pi\ell}{MT_{s}}\right)^{2}$$

$$= \int_{-1/2}^{1/2} |C_{d}(4\pi Bx)|^{2} dx.$$
(14)

By using (13) (14), and (12), the asymptotic expression of J is given by

$$J_{\infty}^{(\beta,\gamma)} = 1 + \omega^2 \beta (1 + 1/\gamma) - 2\omega \beta \mu_1 + \omega^2 \beta (\beta - 1) \mu_2.$$
 (15)

It is worth mentioning that for large SNRs (i.e., in absence of measurement noise), $J_{\infty}^{(\beta,\gamma)}$ reduces to

$$J_{\infty}^{(\beta)} = \lim_{\gamma \to \infty} J_{\infty}^{(\beta,\gamma)} = 1 + \frac{1}{\beta} - 2\mu_1 + \left(1 - \frac{1}{\beta}\right)\mu_2. \quad (16)$$

By also letting β go to infinity, i.e., for highly oversampled signals, $J_{\infty}^{(\beta)}$ reduces to

$$J_{\infty} = \lim_{\beta \to \infty} J_{\infty}^{(\beta)} = 1 - 2\mu_1 + \mu_2.$$
 (17)

Equations (16) and (17) provide us with two floor values that represent the best quality of the reconstructed signal (minimum MSE) we can hope for.

Below we present examples for two jitter probability distributions, namely, Gaussian and uniform, which are often assumed to characterize the jitter affecting AD/DA converters.

A. Gaussian Jitter Distribution

If jitter is assumed to follow a Gaussian distribution with variance σ^2 [8], then the characteristic function $C_d(w)$ is given by

$$C_d(w) = \exp\left(-\frac{1}{2}\sigma^2 w^2\right).$$

By using (13) and (14), we obtain

$$\mu_1 = \frac{1}{\sqrt{8\pi}\eta_g} \operatorname{erf}(\sqrt{2}\pi\eta_g)$$
$$\mu_2 = \frac{1}{4\sqrt{\pi}\eta_g} \operatorname{erf}(2\pi\eta_g)$$

where $\eta_g = \sigma B$ is a dimensionless parameter which relates jitter standard deviation and signal bandwidth. The asymptotic value of J in (15) therefore becomes

$$\begin{split} J_{\infty}^{(\beta,\gamma)} &= 1 + \omega^2 \beta (1+1/\gamma) - 2\omega \beta \frac{\operatorname{erf}(\sqrt{2}\pi \eta_g)}{\sqrt{8\pi} \eta_g} \\ &+ \omega^2 \beta (\beta-1) \frac{\operatorname{erf}(2\pi \eta_g)}{4\sqrt{\pi} \eta_g}; \end{split}$$

however, for the ease of computation, when $\eta_g \ll 1$ (i.e., $\sigma \ll 1/B$), it can be written using its Taylor expansion, which is given by

$$J_{\infty}^{(\beta,\gamma)} = \frac{1}{\beta\gamma + 1} + \frac{4\pi^2\gamma\beta(\gamma+1)}{3(\beta\gamma+1)^2}\eta_g^2 + o\left(\eta_g^4\right). \tag{18}$$

B. Uniform Jitter Distribution

Let us now assume the jitter to be uniformly distributed with pdf given by

$$f_d(z) = \begin{cases} \frac{1}{2d_{\text{max}}}, & -d_{\text{max}} \le z \le d_{\text{max}} \\ 0, & \text{elsewhere} \end{cases}$$

where $d_{\rm max}$ is the maximum jitter, independent of the sampling frequency f_s . In this case, the characteristic function of the jitter is given by

$$C_d(w) = \frac{\sin(d_{\max}w)}{d_{\max}w}.$$

Then, we can write the parameters μ_1 and μ_2 as

$$\mu_1 = \frac{\text{Si}(2\pi\eta_u)}{2\pi\eta_u}$$

$$\mu_2 = \frac{\cos^2(2\pi\eta_u) + 2\pi\eta_u\text{Si}(4\pi\eta_u) - 1}{4\pi^2\eta_u^2}$$

where $\mathrm{Si}(\cdot)$ is the integral sine function and $\eta_u = d_{\max}B$ is a dimensionless parameter which relates maximum jitter and signal bandwidth. The asymptotic value of J in (15) therefore becomes

$$\begin{split} \mathbf{J}_{\infty}^{(\beta,\gamma)} &= 1 + \omega^{2} \beta (1 + 1/\gamma) - 2\omega \beta \frac{\mathrm{Si}(2\pi \eta_{u})}{2\pi \eta_{u}} \\ &+ \omega^{2} \beta (\beta - 1) \frac{\cos^{2}(2\pi \eta) + 2\pi \eta_{u} \mathrm{Si}(4\pi \eta_{u}) - 1}{4\pi^{2} \eta_{u}^{2}} \end{split}$$

which, when $\eta_u \ll 1$ (i.e., $d_{\rm max} \ll 1/B$), can be written using its Taylor expansion as

$$J_{\infty}^{(\beta,\gamma)} = \frac{1}{\beta\gamma + 1} + \frac{4\pi^2\gamma\beta(\gamma+1)}{9(\beta\gamma+1)^2}\eta_u^2 + o\left(\eta_u^4\right). \tag{19}$$

Notice that the variance of the uniformly distributed jitter is given by $d_{\max}^2/3$, while the variance of the Gaussian jitter is σ^2 . When the two variances are equal (i.e., $\sigma^2=d_{\max}^2/3$, which implies $\eta_u^2=\eta_g^2/3$), the expressions of $J_{\infty}^{(\beta,\gamma)}$ in (18) and in (19) are equivalent. This suggests that the reconstruction error depends asymptotically on the jitter variance rather than on the jitter distribution.

In the next section we show that these approximations are extremely accurate, even for η_g , η_u of the order of 10^{-1} .

V. RESULTS

Here, we exploit the expressions we derived in the previous sections to study the performance of the AD/DA conversion as the system parameters vary. As already pointed out in Section IV-B, Gaussian and uniform jitter distributions provide very similar performance in terms of $J_{\infty}^{(\beta,\gamma)}$, thus in the following we present numerical results only for the case of uniformly distributed jitter.

For the ease of representation, we assume that the dominant component of the additive noise is due to quantization, and we express the SNR in absence of jitter γ as a function of the number of quantization bits n of the ADC [16],

$$(\gamma)_{\rm dB} = 6.02n + 1.76.$$

Then, in the following plots we show the value of J as a function of γ or, equivalently, of the number of quantization bits n.

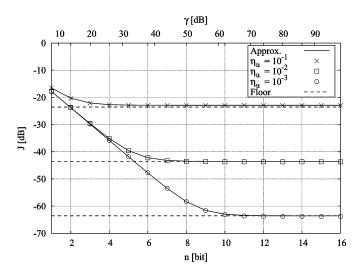


Fig. 1. Comparison between the reconstruction error J derived through (12), the approximation derived through (19) and the floor $J_{\infty}^{(\beta)}$ in (20).

A. Validity of the Asymptotic Analysis

We first assess the validity of the asymptotic expression in (19) as an approximation of the reconstruction performance metric in (12).

In Fig. 1, we compare the approximation obtained through (19) (represented by solid lines) against the values of J computed through (12) (represented by markers), for N'=100. The results are derived for $\eta_u=10^{-1},10^{-2},10^{-3}$, and $\beta=10$. We notice that J, when expressed in decibels, first decreases linearly with n, then, after a sharp transition, it shows a floor whose expression is given by (16). In the case of uniform jitter distribution, for $\beta>1$ and $\eta_u\ll 1$, the floor expression in (16) can be written through its Taylor expansion, as

$$J_{\infty}^{(\beta)} = \frac{4\pi^2}{9\beta} \eta_u^2 + \frac{4\pi^4 (5\beta - 8)}{225\beta} \eta_u^4 + o\left(\eta_u^4\right). \tag{20}$$

In Fig. 1 the floors, computed through the approximated formula in (20), are indicated with the dashed lines.

In general we observe an excellent matching between the approximation computed through (19) and the results computed through (12), even for small values of N and M. We point out that this tight match can be observed for any $\beta>1$ and $\eta_u\ll 1$, and extends to the floor values. This suggests that the asymptotic expression in (19) can be considered instead of J, for evaluating the performance of the A/D and D/A converters; thus, from now on, we will use the expression given in (19).

B. On the Floor of J

We now focus on the floor of $J_{\infty}^{(\beta,\gamma)}$ (i.e., of J) and give an explanation for that. We first notice that the expression in (20) decreases with the oversampling factor β and is lower-bounded by

$$J_{\infty} = \lim_{\beta \to \infty} J_{\infty}^{(\beta)} = \frac{4\pi^4}{45} \eta_u^4 + o\left(\eta_u^4\right).$$

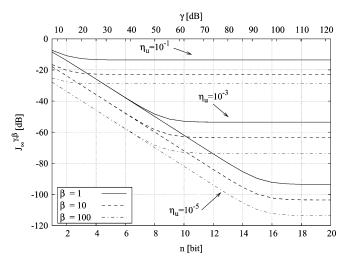


Fig. 2. Approximated $J_{\infty}^{(\beta,\gamma)}$ obtained through (19) as a function of the ADC number of quantization bits n.

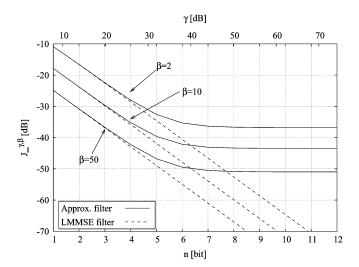


Fig. 3. Comparison of reconstruction performance obtained through the optimal LMMSE filter (7) and the approximated filter (8).

This behavior is confirmed by the results in Fig. 2 where we can appreciate the effect of an increasing β for $\eta_u = 10^{-1}, 10^{-3}, 10^{-5}$.

Then, it is interesting to note that the presence of the floor observed in Figs. 1 and 2 for large values of γ is due to the mismatch between the matrix ${\bf F}$ employed in the reconstruction and the matrix ${\bf V}$ characterizing the sampling system. Indeed, if the jitter were known, we could have used the LMMSE filter ${\bf B}_{\rm opt}$ in (7) instead of the filter ${\bf B}$ in (8) for reconstructing the signal: by using the LMMSE filter, the reconstruction error would decrease monotonically as γ decreases. The comparison between the two filters is shown in Fig. 3, for $\beta=2,10,50$ and $\eta_u=10^{-2}$; there the performance of the LMMSE filter has been derived by considering the values of the jitter to be known, which is not the case in the practice.

C. Optimal Number of Quantization Bits

In the case of unknown jitter, and, thus, in the presence of a floor in the behavior of J, there exists a number of quantization

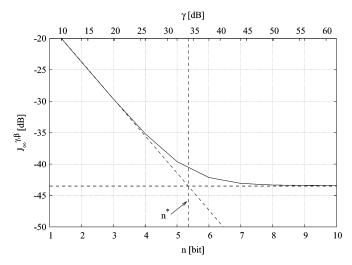


Fig. 4. Estimate of the minimum n required to reach the reconstruction error floor, for $\beta=10$ and $\eta_u=10^{-2}$.

bits $n=n^*$ beyond which a further increase in the ADC precision does not provide a noticeable decrease in the reconstruction error J.

For any given β and η_u , the value of n^* can be estimated as shown in Fig. 4, where the reconstruction error is plotted versus γ (solid line). The horizontal dashed line represents the approximated error floor as in (20), while the dashed line tangent to the reconstruction error in n=1 represents a first-order approximation of J for low values of n. The intersection of the two lines identifies n^* , i.e., the minimum n required at the ADC to reach the reconstruction error floor.

We apply the method described in Fig. 4 for η_u in the range $\{10^{-8}, 10^{-2}\}$, and for $\beta=1,2,5,10,100$. The resulting values of n^* are shown in Fig. 5. Note that n^* is slightly affected by an increase in β , provided that $\beta>1$, and a good compromise for choosing the oversampling rate is $\beta=5$.

These results can provide useful insights to system designers, as highlighted in the following examples.

Example 1: Consider an ADC with n=8 quantization bits, which samples a signal of bandwidth B=100 MHz. The ADC is affected by a jitter whose maximum value is $d_{\rm max}=10$ ps. We are interested in determining the sampling rate so that $J\leq 55$ dB. Since $\eta_u=d_{\rm max}B=10^{-3}$, by looking at Fig. 2 we observe that it is sufficient to have an oversampling ratio $\beta\geq 10$ (i.e., $f_s\geq 1$ GHz).

Example 2: An ADC samples a signal of bandwidth B=1 MHz, with rate $f_s=100$ MHz (i.e., $\beta=100$). Thus, when the maximum jitter is $d_{\rm max}=50$ ps, we have $\eta_u=5\cdot 10^{-5}$, and from Fig. 5 we observe that $n^*=13$ is sufficient to reach the reconstruction error floor. When instead $d_{\rm max}=1$ ps (i.e., $\eta_u=10^{-6}$), then at least 19 quantization bits are required to achieve the error floor.

VI. CONCLUSION

We studied the performance of analog-to-digital and digital-to-analog converters, in presence of clock jitter and quantization errors. We considered that a linear filter approximating the LMMSE filter is used for signal reconstruction, and evaluated the system performance in terms of minimum square error

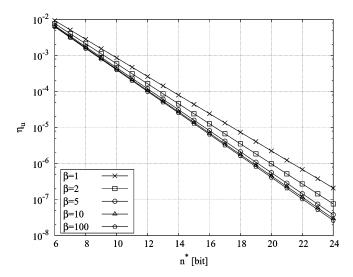


Fig. 5. Minimum number of bits n^* required to reach the floor of $J_{\infty}^{(\beta,\gamma)}$ as a function of β and η_n .

between the reconstructed signal and the original one. Through asymptotic analysis, we derived analytical expressions of the MSE which provide an accurate and simple method to evaluate the behavior of AD/DA converters as clock jitter, number of quantization bits, signal bandwidth and sampling rate vary. In particular, we looked at two different probability distributions of the jitter, namely, Gaussian and uniform distribution, and we showed that our asymptotic approach provides an excellent approximation of the MSE even for small values of the system parameters. Furthermore, we derived the MSE floor, which represents the best reconstruction quality level we can hope for and gives useful insights for the design of AD/DA converters.

APPENDIX A PROOF OF (10) AND (11)

To derive (10) and (11), first recall the expression in (4), from which we notice that the ratio $t_m/(MT_s)$ that appears in (5) is given by

$$\frac{t_m}{MT_s} = \frac{m}{M} + \frac{d_m}{MT_s}.$$

Therefore, we obtain

$$\operatorname{tr}\{\mathbb{E}_{d}[\mathbf{F}\mathbf{V}^{\dagger}]\} \\
= \frac{1}{N^{2}}\mathbb{E}_{d}\left[\sum_{\ell=-N'}^{N'} \sum_{m=0}^{M-1} e^{-j2\pi\ell m/M} e^{+j2\pi\ell(m+d_{m}/T_{s})/M}\right] \\
= \frac{1}{N^{2}}\mathbb{E}_{d}\left[\sum_{\ell=-N'}^{N'} \sum_{m=0}^{M-1} e^{+j2\pi\ell \frac{d_{m}}{MT_{s}}}\right] \\
= \frac{1}{N^{2}}\sum_{\ell=-N'}^{N'} \sum_{m=0}^{M-1} \mathbb{E}_{d}\left[e^{+j2\pi\ell \frac{d_{m}}{MT_{s}}}\right].$$
(21)

By defining

$$C_d(w) = \mathbb{E}_d[\exp(jwz)] = \int \exp(jwz)f_d(z)dz$$

as the characteristic function of the jitter d, we observe that $\mathbb{E}_d[\mathrm{e}^{+\mathrm{j}2\pi\ell(d_m)/(MT_s)}]=C_d((2\pi\ell)/(MT_s))$. Therefore,

$$\operatorname{tr}\{\mathbb{E}_{d}[\mathbf{F}\mathbf{V}^{\dagger}]\} = \frac{1}{N^{2}} \sum_{\ell=-N'}^{N'} \sum_{m=0}^{M-1} C_{d}\left(\frac{2\pi\ell}{MT_{s}}\right)$$
$$= \frac{M}{N^{2}} \sum_{\ell=-N'}^{N'} C_{d}\left(\frac{2\pi\ell}{MT_{s}}\right). \tag{22}$$

Similarly, we write

$$\operatorname{tr}\{\mathbb{E}_{d}[\mathbf{F}\mathbf{V}^{\dagger}\mathbf{V}\mathbf{F}^{\dagger}]\}$$

$$=\frac{1}{N^{3}}\mathbb{E}_{d}\left[\sum_{\ell,\ell',m,m'} e^{-j2\pi\ell m/M} e^{+j2\pi\ell'(m+d_{m}/T_{s})/M} e^{-j2\pi\ell'(m'+d_{m'}/T_{s})/M} e^{-j2\pi\ell m'/M}\right]$$

$$=\frac{1}{N^{3}}\mathbb{E}_{d}\left[\sum_{\ell,\ell',m,m'} e^{-j2\pi(\ell-\ell')(m-m')/M} e^{+j2\pi\ell'(d_{m}-d_{m'})/(MT_{s})}\right]$$

$$=L_{1}+L_{2}$$
(23)

where L_1 and L_2 are the contributions to (23) when m=m' and $m \neq m'$, respectively. Thus, when m=m', we have

$$L_1 = \frac{1}{N^3} \mathbb{E}_d \left| \sum_{\ell, \ell', m, m'} 1 \right| = \frac{M}{N}$$

while when $m \neq m'$ we have

$$L_{2} = \frac{1}{N^{3}} \sum_{\ell,\ell',m} \sum_{m' \neq m} e^{-j2\pi(\ell-\ell')(m-m')/M}$$

$$\cdot C_{d} \left(\frac{2\pi\ell'}{MT_{s}}\right) C_{d} \left(-\frac{2\pi\ell'}{MT_{s}}\right)$$

$$= \frac{1}{N^{3}} \sum_{\ell,\ell',m} \sum_{m' \neq m} e^{-j2\pi(\ell-\ell')(m-m')/M} \left| C_{d} \left(\frac{2\pi\ell'}{MT_{s}}\right) \right|^{2}$$

$$= L_{3} + L_{4}$$
(24)

where L_3 and L_4 are the contributions to (24) when $\ell = \ell'$ and $\ell \neq \ell'$, respectively. We obtain

$$L_{3} = \frac{M(M-1)}{N^{3}} \sum_{\ell'} \left| C_{d} \left(\frac{2\pi\ell'}{MT_{s}} \right) \right|^{2}$$
and
$$L_{4} = -\frac{M}{N^{3}} \sum_{\ell} \sum_{\ell' \neq \ell} \left| C_{d} \left(\frac{2\pi\ell'}{MT_{s}} \right) \right|$$

$$= -\frac{M(N-1)}{N^{3}} \sum_{\ell} \left| C_{d} \left(\frac{2\pi\ell}{MT_{s}} \right) \right|^{2}.$$

In conclusion, we get

$$\operatorname{tr}\{\mathbb{E}_d[\mathbf{F}\mathbf{V}^{\dagger}\mathbf{V}\mathbf{F}^{\dagger}]\} = \frac{M}{N} + \frac{M(M-N)}{N^3} \sum_{\ell} \left| C_d \left(\frac{2\pi\ell}{MT_s} \right) \right|^2.$$

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